

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

the Application of

Ranjan RAY

Serial No.: 10/782,927

Filed: February 23, 2004

For: FINE GRAINED SPUTTERING TARGETS OF COBALT AND NICKEL BASE ALLOYS MADE VIA CASTING IN METAL MOLDS FOLLOWED BY HOT FORGING AND ANNEALING AND METHODS OF MAKING SAME

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to Rules 56 and 98, Applicants hereby call the attention of the Patent Office to the references listed on the attached Form PTO 1449.

Applicants present these references so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see <u>Beckman Instruments</u>, <u>Inc. v. Chemtronics</u>, <u>Inc.</u>, 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir. 1970). Also see Patent Office Rule 104. Applicants respectfully request that these references be expressly considered during the prosecution of this application and made of record herein and appear among the "References Cited" on any patent to issue herefrom.

Respectfully submitted,

Date:

APV/paw

ATTORNEY DOCKET NO. APV31670

Bu:

Anthony P. Venturino Registration No. 31,674

STEVENS, DAVIS, MILLER & MOSHER, L.L.P. 1615 L STREET, N.W., SUITE 850 WASHINGTON, D.C. 20036

TEL. 202-785-0100 / FAX. 202-408-5200

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APPLICANT Ranjan RAY

FILING DATE February 23, 2004 GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCU	MENT NU	MBER		DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS

		DOCU	MENT NU	JMBER.		DATE	COUNTRY	CLASS	SUBCLASS	TRANSLA	TION
										YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

.	US Published Patent Application No. 2004/0060685A1, (Ser. No. 10/674,435), RAY et al., filed October 1, 2003, published April 1, 2004
	US Published Patent Application No. 2004/0055725A1, (Ser. No. 10/448,116), RAY et al., filed May 30, 2003, published March 25, 2004
	US Published Patent Application No. 2004/0040690A1, (Ser. No. 10/443,807), RAY et al., filed May 23, 2003, published March 4, 2004
	US Patent Application Serial No. 10/838,266, RAY et al., filed May 5, 2004

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. PATENT DOCUMENTS

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NITIAL	+			MENT NO		,		DATE	NAME	CLASS	SUBCLASS	IF APPROPRIATE
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